

M.E. Second Semester (Electrical (Electronics & Power) Engineering) (New-CGS)  
**13321 : Digital Instrumentation : 2 EEPME 2**

P. Pages : 2

Time : Three Hours



**AW - 3854**

Max. Marks : 80

- Notes :
1. Due credit will be given to neatness and adequate Dimensions.
  2. Assume suitable data wherever necessary.
  3. Illustrate your answer necessary with the help of neat sketches.

**SECTION – A**

1. a) Explain the different types of measurement errors. What is SPC? Give its applications. 7
- b) Explain: 6
  - i) Quantum hall effect
  - ii) Josephson effect
  - iii) Von Klitzing constant

**OR**

2. What do you mean by standard? What is the significance of standard? Also explain the various international standards. 13
3. a) Discuss the open loop and closed loop SHA architecture. 6
- b) Discuss the D to A converter architectures based on Resistor ladders. Also define various DAC performance parameters. 8

**OR**

4. Explain the basic SHA operation with the help of its four mode specifications & necessary diagrams. 14
5. What is TDR? Explain TDR applications and its different types. 13

**OR**

6. a) Explain the basic dual slope ADC technique used in digital multimeters with its diagram and measurement cycle. 8
- b) Explain the following parameter for amplitude measurements: 5
  - i) Average value
  - ii) RMS value
  - iii) Mean absolute deviation
  - iv) Crest factor
  - v) Form factor

**SECTION – B**

7. a) Explain frequency measurement and frequency ratio measurement with reference to electronic counters. 7

- b) Explain the working of AWG based on direct digital synthesis. 6

**OR**

8. a) Draw and explain block diagram of modulation analyzer. 7

- b) Explain down conversion techniques. 6

9. a) Compare analog oscilloscope, digital oscilloscope and spectrum analyzer. On what basis, do we select logic analyzer or oscilloscope for analysis. 8

- b) Explain dynamic signal analysis with the help of dynamic signal analyser. 5

**OR**

10. a) Explain implementation and working of swept tuned spectrum analyzer. 7

- b) Explain the three common techniques used to make frequency domain measurements. 6

11. a) Explain briefly IEEE 488 BUS. 7

- b) Explain in detail VXI Bus. 7

**OR**

12. a) Explain RS232 serial bus standard with DCE and DTE interfaces. 8

- b) What is VLSI testing? Explain in brief with Automatic Test Equipment (ATE). 6

\*\*\*\*\*